## **Power MOSFET**

## 60 V, 44 m $\Omega$ , 20 A, Dual N-Channel

#### **Features**

- Small Footprint (5x6 mm) for Compact Designs
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- 175°C Operating Temperature
- NVMFD5485NLWF Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- This is a Pb-Free Device

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	60	V
Gate-to-Source Voltage	Gate-to-Source Voltage			±20	V
Continuous Drain Current R <sub>0JC</sub> (Notes 1, 2, 4)	Steady State	T <sub>C</sub> = 25°C	I <sub>D</sub>	19.5	Α
		T <sub>C</sub> = 100°C		13.8	
Power Dissipation R <sub>0JC</sub> (Notes 1, 2)		T <sub>C</sub> = 25°C	$P_{D}$	38.5	W
		T <sub>C</sub> = 100°C		19.2	
Continuous Drain	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	5.3	Α
Current R <sub>0JA</sub> (Notes 1, 3 & 4)		T <sub>A</sub> = 100°C		3.8	
Power Dissipation R <sub>0JA</sub> (Notes 1 & 3)		T <sub>A</sub> = 25°C	$P_{D}$	2.9	W
		T <sub>A</sub> = 100°C		1.4	
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I <sub>DM</sub>	113	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	-55 to 175	ç
Source Current (Body Diode)			I <sub>S</sub>	37	Α
Single Pulse Drain-to-Source Avalanche Energy (T <sub>J</sub> = 25°C, V <sub>DD</sub> = 50 V, V <sub>GS</sub> = 10 V, $I_{L(pk)}$ = 25 A, L = 0.1 mH, $R_G$ = 25 $\Omega$ )			E <sub>AS</sub>	31	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 2)	$R_{\theta JC}$	3.9	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	52	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted to an ideal (infinite) heat sink.
- 3. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second are higher but are dependent on pulse duration and duty cycle.

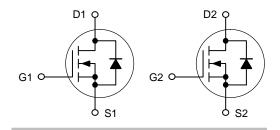


#### ON Semiconductor®

#### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
60 V	44 mΩ @ 10 V	20 A
	60 mΩ @ 4.5 V	20 A

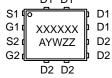
#### **Dual N-Channel**





# MARKING DIAGRAM D1 D1

DFN8 5x6 (SO8FL) CASE 506BT



XXXXXX = 5485NL

(NVMFD5485NL) or

5485LW

(NVMFD5485NLWF)

A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>			
NVMFD5485NLT1G	DFN8 (Pb-Free)	1500/ Tape & Reel			
NVMFD5485NLT3G	DFN8 (Pb-Free)	5000/ Tape & Reel			
NVMFD5485NLWFT1G	DFN8 (Pb-Free)	1500/ Tape & Reel			
NVMFD5485NLWFT3G	DFN8 (Pb-Free)	5000/ Tape & Reel			

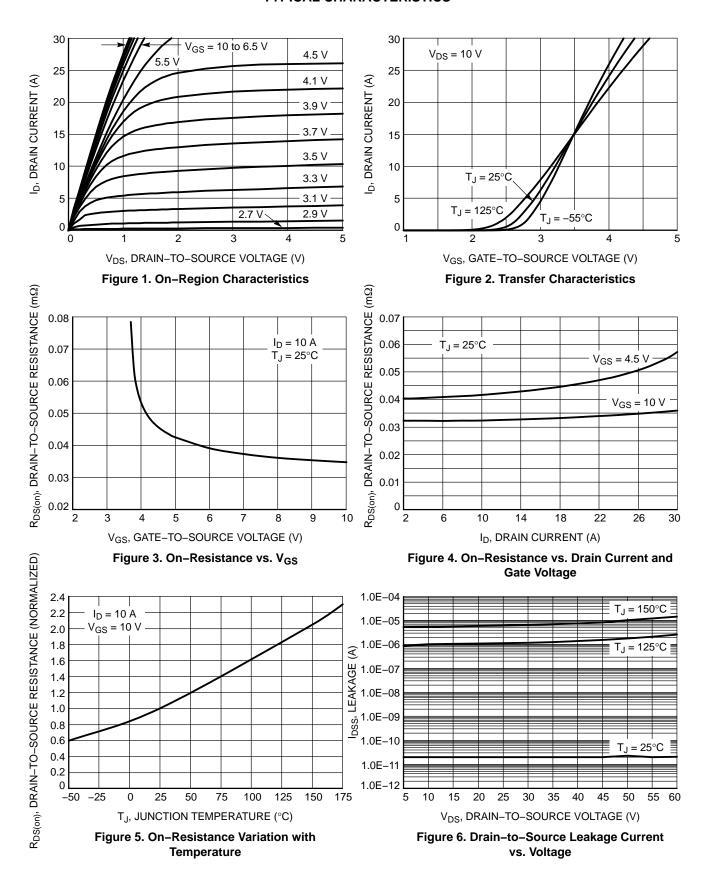
<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	-		•		-	-	-
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	Reference to 25°C I <sub>D</sub> = 250 μA			67		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 60 V	T <sub>J</sub> = 25°C			1.0	μΑ
			$T_J = 125^{\circ}C$			10	1
Gate-to-Source Leakage Current	$I_{GSS}$	$V_{DS} = 0 \text{ V}, V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	: 250 μA	1.5		2.5	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	Reference to 25°C I <sub>D</sub> = 250 μA			-4.86		mV/°C
Drain-to-Source On Resistance	te On Resistance $R_{DS(on)}$ $V_{GS} = 10 \text{ V}, I_D = 15 \text{ A}$		= 15 A		33	44	mΩ
	, ,	$V_{GS} = 4.5 \text{ V}, I_{D}$	= 10 A		42	60	
CHARGES AND CAPACITANCES	•		•		•	•	•
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz, } V_{DS} = 25 \text{ V}$			560	1	pF
Output Capacitance	C <sub>oss</sub>				126		
Reverse Transfer Capacitance	C <sub>rss</sub>				58		
Total Gate Charge	Q <sub>G(TOT)</sub>				20		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub>	s = 48 V,		0.52		1
Gate-to-Source Charge	Q <sub>GS</sub>	I <sub>D</sub> = 10 A			1.9		1
Gate-to-Drain Charge	$Q_GD$				7.9		<b>1</b>
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 48 \text{ V},$ $I_D = 10 \text{ A}$			11.5		nC
SWITCHING CHARACTERISTICS (N	ote 6)						
Turn-On Delay Time	t <sub>d(on)</sub>				9.5		ns
Rise Time	t <sub>r</sub>	Vcs = 4.5 V. Vns	s = 48 V.		26.6		1
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 48 \text{ V},$ $I_D = 10 \text{ A}, R_G = 2.5 \Omega$			27.8		1
Fall Time	t <sub>f</sub>				23.7		
DRAIN-SOURCE DIODE CHARACTI	RISTICS		•				
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.93	1.2	V
-		I <sub>S</sub> = 15 A	T <sub>J</sub> = 125°C		0.83		1
Reverse Recovery Time	t <sub>RR</sub>		1 -		28.9		ns
Charge Time	t <sub>a</sub>	$V_{GS} = 0 \text{ V, } d_{IS}/d_t = 100 \text{ A/}\mu\text{s,}$ $I_S = 10 \text{ A}$			23.2		
Discharge Time	t <sub>b</sub>				5.6		
Reverse Recovery Charge	Q <sub>RR</sub>				35.5		nC
PACKAGE PARASITIC VALUES						•	
Source Inductance	L <sub>S</sub>		1		0.93		nH
Drain Inductance	L <sub>D</sub>	T <sub>A</sub> = 25°C			0.005		┥
Gate Inductance	L <sub>G</sub>				1.84		╡
Gate Resistance	R <sub>G</sub>				12	<del>                                     </del>	Ω

<sup>5.</sup> Pulse Test: pulse width = 300  $\mu$ s, duty cycle  $\leq$  2%.
6. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**



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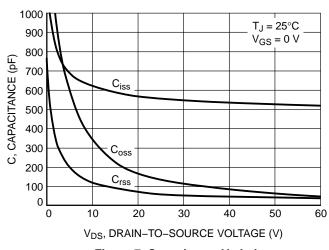


Figure 7. Capacitance Variation

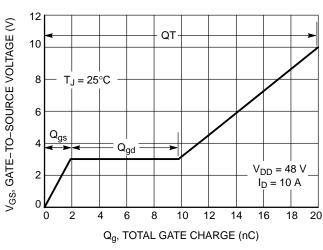


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

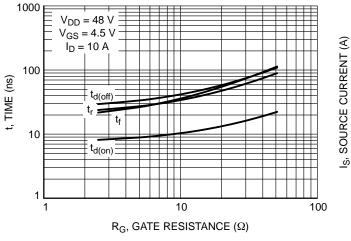


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

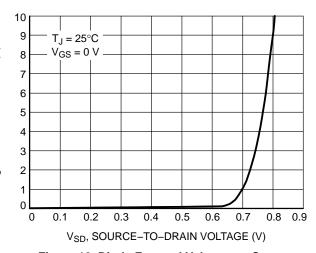


Figure 10. Diode Forward Voltage vs. Current

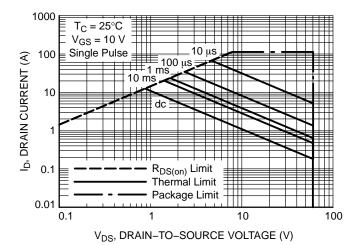


Figure 11. Maximum Rated Forward Biased Safe Operating Area

#### **TYPICAL CHARACTERISTICS**

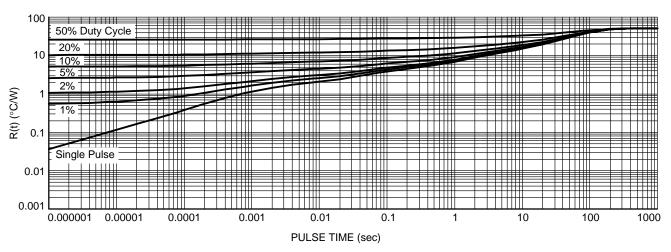
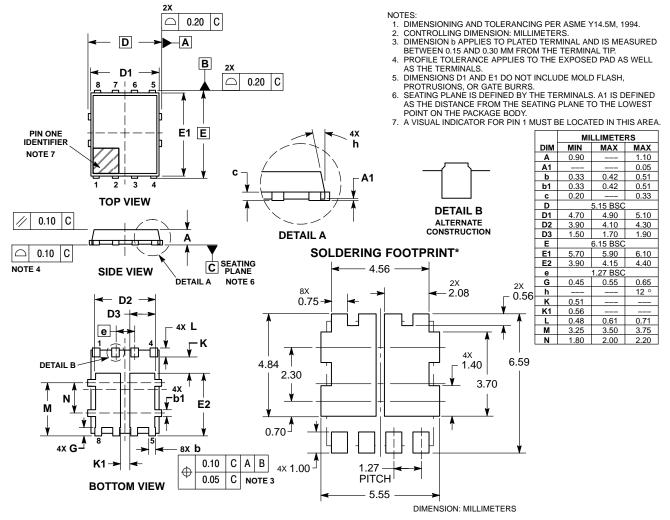


Figure 12. Thermal Response

#### PACKAGE DIMENSIONS

#### DFN8 5x6, 1.27P Dual Flag (SO8FL-Dual)

CASE 506BT ISSUE E



<sup>\*</sup>For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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